#### Results from the LCLS X-band transverse deflector with femtosecond temporal resolution

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## X-band transverse deflector (XTCAV) at LCLS

- Background/motivation of the project
- Principle, design and realization
- Recent experimental results
  Discussion

Reference: C. Behrens et al., Nature Communications, 5:3762 (2014).





# **XFELs: the 4<sup>th</sup> generation light source**

- ~10 orders higher peak brightness and ~3 orders shorter pulse duration.
- X-ray FELs: probe of the ultra-small and ultra-fast worlds;
- Temporal diagnostics are very challenging.

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## **Motivation / Goal**

- Measure X-ray pulse duration and temporal shape;
- Resolution: ~fs, shorter is better...
- Single-shot, non-invasive to operation, large dynamic range.
- Other methods have been studied: THz streaking, statistical (spectral) analysis, correlation...
- We proposed to measure the lasing effect on the electron bunch with a transverse deflector in 2011. (*Ding et al., PRSTAB 14, 120701*)
- This device was commissioned in 2013 summer, and now it is operational.





#### TCAV: an RF "streak" camera for e-beam



X-band TCAV:	
Frequency	11.424 GHz
Maximum kick	44 MV@35MW

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Temp.  
resol. 
$$\sigma_{t,R} \propto \frac{\lambda_{rf}}{V_0} \sqrt{E \frac{\varepsilon_{N,x}}{\beta_x(s_0)}}$$

<b>HXR:</b> (14GeV)	<b>SXR:</b> (4.3GeV)
Calib.factor ~40,	Calib. factor ~120,
$\sigma_{t,R} \sim 3 fs;$	$\sigma_{t,R} \sim 1 fs;$

#### How to retrieve x-ray temporal profile?



0MeV/e



(Ding et al., PRSTAB 14, 120701)



## **XTCAV** at LCLS



## <u>Measurement</u> examples: 4.7GeV, 150pC (raw images)



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### **Data processing**



- Calibration in time and energy;
- Record baseline images (FEL-off);
- Image processing, slicing and averaging baseline data;
- Take single-short image (FEL-on) and other beam parameters;
- Reconstruct electron and x-ray temporal profile.





## **Recent experimental results**

- X-ray pulse length reconstruction
- FEL lasing characterization
- Lasing control with slotted foil
- Two-bunch two-color lasing
- Micro-bunching studies





## Short pulse: 20pC, 1keV examples





#### **Observed particle trapping at deep saturation**





Slide courtesy P. Emma



## **Slotted-foil measured examples**

#### (double-slot, lasing off)



(single-slot, 1keV)



## **Double-bunch (two-color) example**





#### **Direct & quantitative study of micro-bunching**



## Discussion

- Demonstrated single-shot, non-invasive x-ray temporal diagnostics with fs resolution using XTCAV;
- Best resolution achieved is about 1 fs rms @ SXR, and 4 fs rms @ HXR.
- An upgrade to double the deflecting voltage using SLED technology is ongoing (J. Wang et al. poster: THPP125).





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